

Form 1449 (Modified)				Atty. Docket No. HIT1P026 / HSJ9-2003-0145US1	Application No.: Unassigned
Information Disclosure Statement By Applicant (Use Several Sheets if Necessary)				Applicant: H. Gill	
				Filing Date: Herewith	Group Art Unit: Unassigned

U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
A	A	6,515,573	02/04/2003	Dong et al.	338	32	06/19/2000
	B	6,501,626	12/31/2002	Gill	360	324.11	05/03/2000
	C	6,396,668	05/28/2002	Mao et al.	360	314	07/24/2000
	D	6,327,121	12/04/2001	Nagasawa et al.	360	324.11	11/13/1998
	E	6,292,335	09/18/2001	Gill	360	324.11	06/25/1999
	F	6,150,045	11/21/2000	Saito et al.	428	692	09/16/1998
	G	6,074,767	06/13/2000	Lin	428	692	03/12/1998
	H	6,064,552	05/16/2000	Iwasaki et al.	360	113	03/17/1998
	I	6,046,891	04/04/2000	Yoda et al.	360	113	02/11/1998
	J	5,661,621	08/26/1997	Kobayashi et al.	360	113	07/31/1995
	K	5,657,191	08/12/1997	Yuan	360	113	09/18/1995
	L	2001/0028541	10/11/2001	Gill	360	324.12	06/11/2001

Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
A	M	2001-160640	12.06.2001	JP	H01L	43/08		
	N	2002-270920	20.09.2002	JP	H01L	43/08		
	O	2000-163717	16.06.2000	JP	G11B	5/39		
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Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
A	R	Cho, Hae Seok, "Effect of Pinning Field on the Magnetization in Patterned Synthetic Antiferromagnetic Spin Valves," Journal of Applied Physics, May 1, 2000, Volume 87, Number 9
	S	
	T	

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
<i>A/H</i>	A	2001/0053052	12/20/2001	Ihara et al.	360	324.1	03/06/2001
<i>Z</i>	B	2001/0050834	12/13/2001	Hasegawa et al.	360	324.12	06/25/2001
<i>Z</i>	C	2002/0154456	10/24/2002	Carey et al.	360	324.11	04/24/2001
<i>Z</i>	D	2002/0114113	08/22/2002	Lederman et al.	360	324.11	03/28/2002
<i>Z</i>	E	2002/0114111	08/22/2002	Zhu	360	324.11	02/20/2001
<i>Z</i>	F	2002/0097538	07/25/2002	Seyama et al.	360	324.11	03/29/2001
<i>Z</i>	G	2002/0085323	07/04/2002	Smith et al.	360	324.12	01/04/2001
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							Yes	No
	M							
	N							
	O							
	P							

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication					
	R						
	S						
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Examiner	<i>A. Heinz</i>			Date Considered <i>5/13/05</i>			

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